

# **Features**

- Advanced Trench Technology
- Provide Excellent RDS(ON) and Low Gate Charge

### **Application**

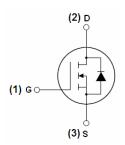
- Load Switch
- PWM Application

#### **Product Summary**



<b>V</b> ps	30	V
R DS(on),TYP@ VGS=10 V	5.0	mΩ
lo	80	Α





## **Absolute Maximum Ratings** (Tc=25℃ unless otherwise specified)

Symbol	Parameter		Max.	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
I_	Continuous Drain Current	T <sub>C</sub> = 25°C	80	Α
l <sub>D</sub>	Continuous Drain Current	T <sub>C</sub> = 100℃	50	Α
I <sub>DM</sub>	Pulsed Drain Current note1		320	Α
Eas	Single Pulsed Avalanche Energy note2		88	mJ
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25°C	75	W
R <sub>0</sub> JC	Thermal Resistance, Junction to Case		1.68	°C /\/\/
R <sub>θJA</sub>	Thermal Resistance, Junction to Ambient		62	*C/W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +175	$^{\circ}\!\mathbb{C}$



#### **Electrical Characteristics** (T<sub>C</sub>=25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units	
Off Charac	cteristic		I .	Į.			
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V,I <sub>D</sub> =250µA	30	-	_	V	
loss	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> = 0V, T <sub>J</sub> =25℃	-	-	1		
		V <sub>DS</sub> =24V, V <sub>GS</sub> = 0V, T <sub>J</sub> =125°C	-	-	10	uA	
Igss	Gate to Body Leakage Current	V <sub>DS</sub> =0V,V <sub>GS</sub> = ±20V	-	-	±100	nA	
On Charac	cteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250µA	1.0	1.6	2.5	V	
	Static Drain-Source on-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	5.0	6	mΩ	
$R_{DS(on)}$	note3	V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A	-	6.8	12		
<b>g</b> FS	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =10A	-	20	-	S	
Dynamic C	Characteristics						
C <sub>iss</sub>	Input Capacitance	05)/// 05)/	-	1914	_	pF	
Coss	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$	-	270	_	pF	
Crss	Reverse Transfer Capacitance	f = 1.0MHz	-	218	-	pF	
Qg	Total Gate Charge	\/ -45\/ L -20A	-	11.1	-	nC	
Qgs	Gate-Source Charge	V <sub>DS</sub> =15V, I <sub>D</sub> =20A, V <sub>GS</sub> =4.5V	-	1.85	-	nC	
Q <sub>gd</sub>	Gate-Drain("Miller") Charge	VGS -4.5V	-	6.8	-	nC	
Switching	Characteristics						
t <sub>d(on)</sub>	Turn-on Delay Time		-	7.5	_	ns	
t <sub>r</sub>	Turn-on Rise Time	V <sub>DS</sub> =15V,	-	14.5	-	ns	
t <sub>d(off)</sub>	Turn-off Delay Time	$I_D$ =15A, R <sub>G</sub> =3.3Ω,	-	35.2	-	ns	
t <sub>f</sub>	Turn-off Fall Time	V <sub>GS</sub> =10V	-	9.6	-	ns	
Drain-Sou	rce Diode Characteristics and Maxim	um Ratings	•	•			
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	80	Α	
Ism	Maximum Pulsed Drain to Source Diode Forward Current		-	-	320	Α	
VsD	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> =30A	-	-	1.2	V	
trr	Body Diode Reverse Recovery Time		-	32	-	ns	
Qrr	Body Diode Reverse Recovery Charge	Is=30A,dI/dt=100A/µs	-	12	-	nC	

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

- 2. EAS condition: TJ=25  $^{\circ}\text{C}$  ,VDD=25V,VGS=10V, L=0.1mH, IAS=42A, RG=25  $\Omega$
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤2%



# **Typical Performance Characteristics**

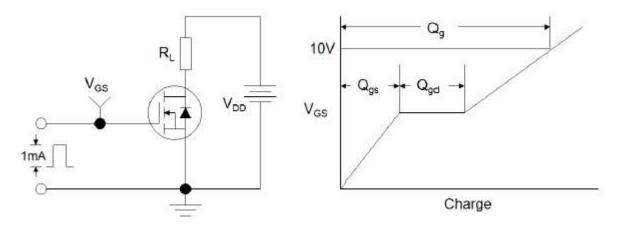


Figure1:Gate Charge Test Circuit & Waveform

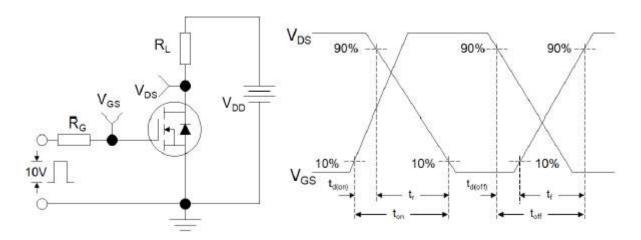


Figure 2: Resistive Switching Test Circuit & Waveforms

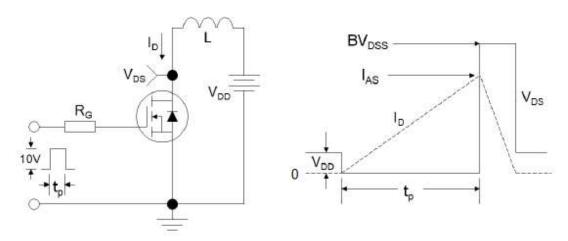
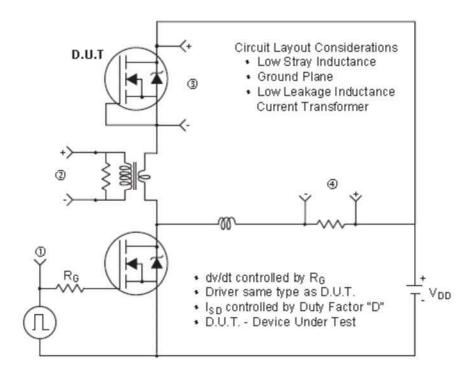


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms



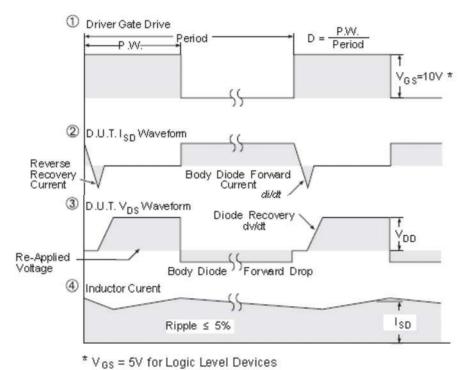


Figure 4:Peak Diode Recovery dv/dt Test Circuit & Waveforms (For N-channel)



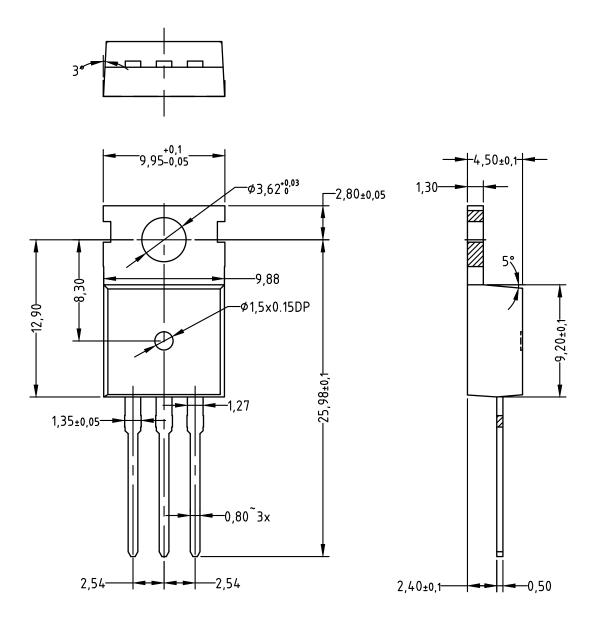
# **Ordering and Marking Information**

Ordering Device No.	Marking	Package	Packing	Quantity
ASDM30N80P-T	30N80	TO-220	Tube	50/Tube

PACKAGE	MARKING
TO-220	AS □□□→ Lot Number 30N80 □□□□→ Date Code



# TO-220







**30V N-Channel MOSFET** 

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